Applicant(s)/Patent Under Application/Control No. Reexamination 10/517,887 ORTT ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 David W. Scheuermann 2834 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В С US-D US-Ε US-F US-G US-Н US-US-١

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06155268 A	06-1994	Japan	NAKAZAWA, HIRONOBU	
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U								
	٧								
	w								
	х								

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

US-

US-

US-

US-

J K

L

М